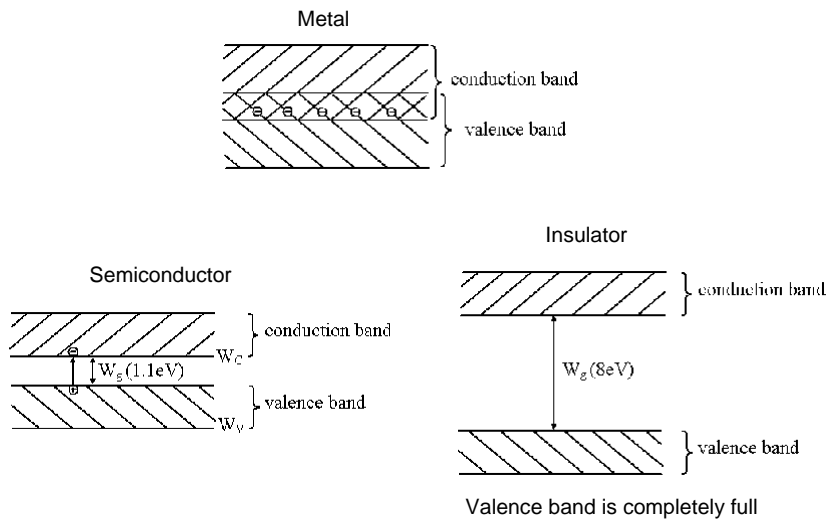


OPTI 380A

Intermediate Optics Lab 1 and 2: Semiconductor Light Sources

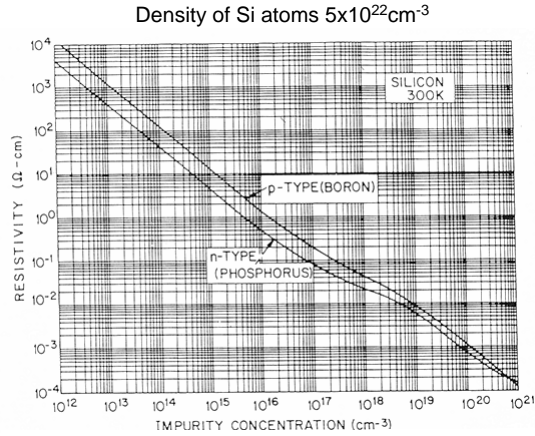
Tom Milster
Professor, College of Optical Sciences,
University of Arizona
milster@arizona.edu

Electronic Properties



Semiconductors

- ❑ Intrinsic (pure) semiconductor, majority carrier concentration $n(\text{Si}) \sim 10^{10} \text{ cm}^{-3}$
- ❑ Extrinsic (doped) semiconductor
- ❑ Control of resistivity of silicon by over 9 orders of magnitude by adding small amount of impurities or dopants
- ❑ p-type, majority carrier is hole
- ❑ n-type, majority carrier is electron



This is what makes everything possible!
Transistors, semiconductor lasers, diode detectors, CCDs ...
which lead to computer, internet, mp3 players, digital camera ...

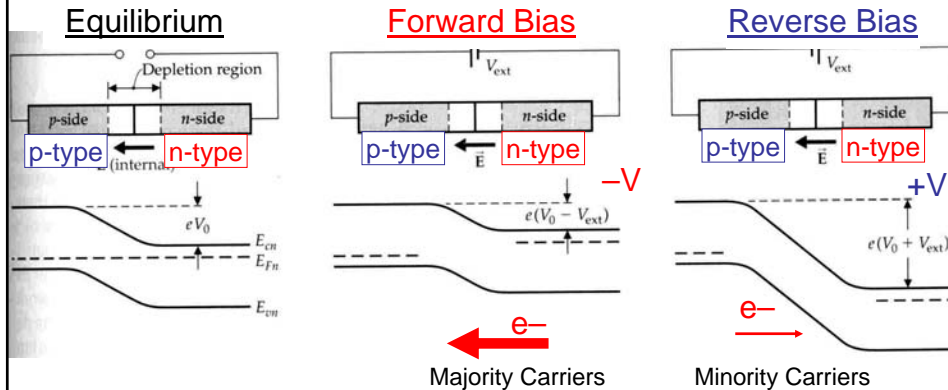
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Semiconductor Light Sources I

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PN Junction: Band Diagram under Bias

- ❑ **Forward Bias:** negative voltage on n-side decreases built-in junction potential \rightarrow higher current of (majority) electrons from n to p-side.
- ❑ **Reverse Bias:** positive voltage on n-side increases junction potential \rightarrow only very low current of (minority) electrons from p to n-side.



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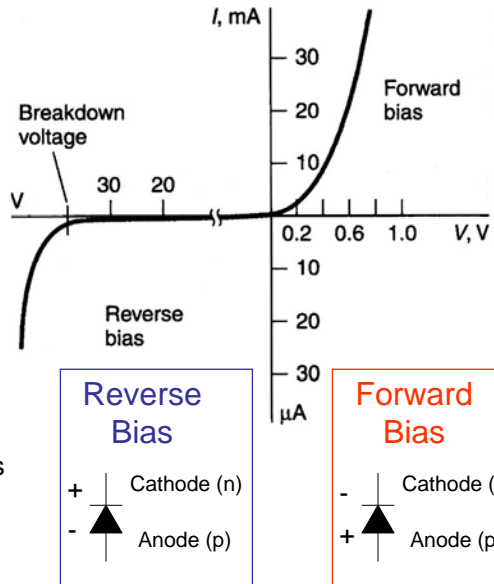
4

PN Junction: I-V Characteristics

Current-Voltage Relationship

$$I = I_0 [e^{eV/kT} - 1]$$

- **Forward Bias:** current exponentially increases.
- **Reverse Bias:** low leakage current equal to $\sim I_0$.
- "Rectifying" pn junction passes current in only one direction!



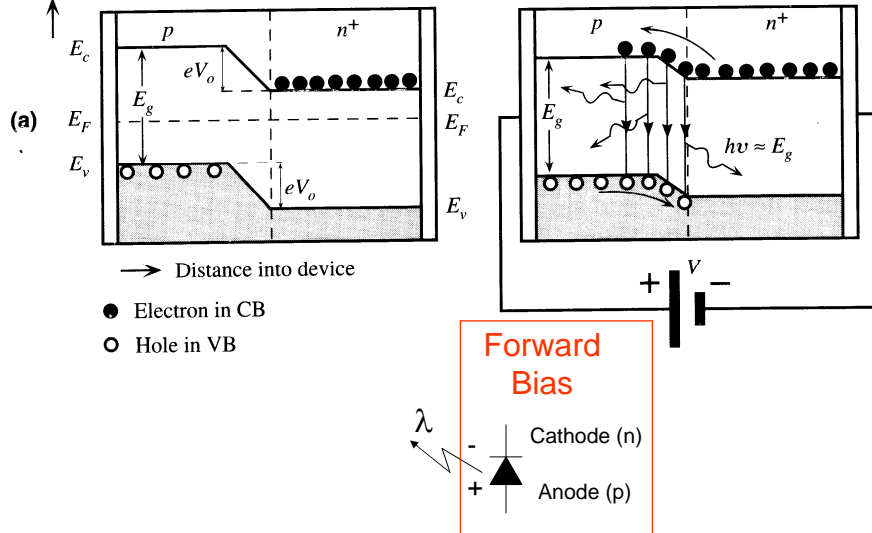
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Light Emitting Diode (LED)

Electron energy

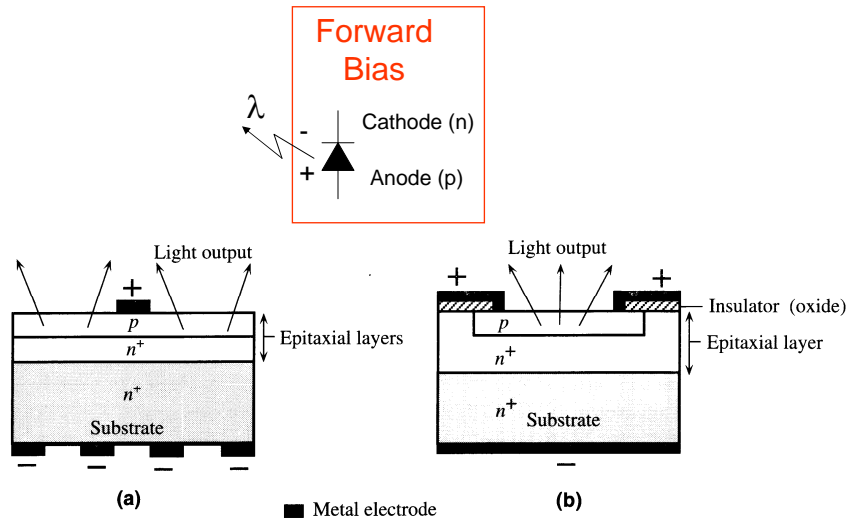


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Light Emitting Diode (LED)



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LED Far-Field Pattern

- LED far-field patterns vary greatly, depending on the electrode layout and the type of lens in which the LED is encased.
- The LED you will be using in the lab has this characteristic:

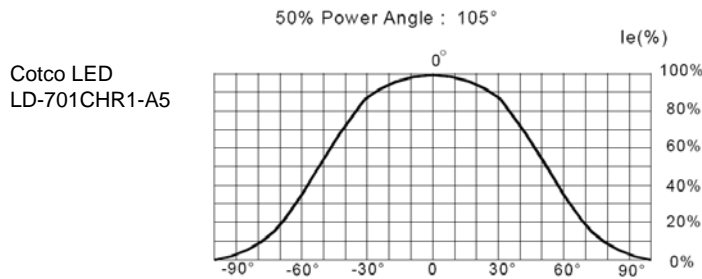


FIG.5 FAR FIELD PATTERN

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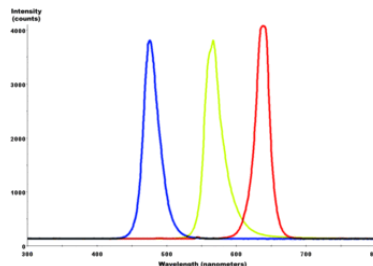
Light Emitting Diode (LED)

- ❑ Semiconductor that emits incoherent narrow-spectrum of light upon application of a current.
- ❑ An LED is a semiconductor diode with a structure called the p-n junction.



Spectra of blue, yellow-green and red LEDs
FWHM is ~24-27 nm

Blue, green and red LEDs



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Other LED Characteristics for This Lab

Cotco LED LD-701CHR1-A5

Half Power Δ WL=23nm
Half Power WL=624nm

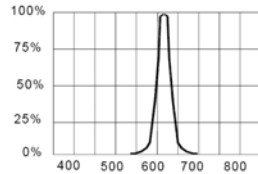
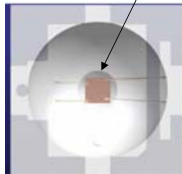


FIG. 3 RELATIVE LUMINOUS FLUX VS. WAVELENGTH.

Emission area ~ 1mm²

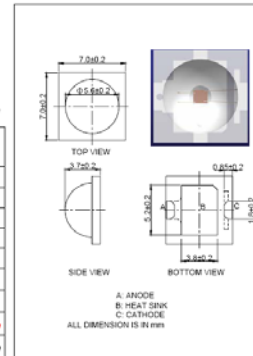


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Features

- High luminous flux output for illumination
- Exposed pad design for excellent heat transfer
- Designed for high current operation
- Reflow soldering applicable

Package Outline



Absolute Maximum Ratings at Ta = 25°C (on metal core PCB)*

Items	Symbol	Absolute maximum Rating	Unit
Forward Current	I_f	450	mA
Peak Forward Current**	I_{fP}	700	mA
Reverse Voltage	V_R	5	V
Power Dissipation	P_D	1.2	W
Operation Temperature	T_{op}	-40 ~ +85	°C
Storage Temperature	T_{stg}	-40 ~ +85	°C
Junction temperature	T_j	+115	°C
Junction-to-Ambient***	θ_{ja}	45	°C/W
Junction-to-case***	θ_{jc}	20	°C/W

*Metal core PCB defines as good heat transmission substrate (thickness of 2.0mm Al-based PCB in 20x20mm, θ_{jc} < 20°C/W could do)
** Where pulse width <= 0.1msec, duty cycle <= 1/10 *** Rth test condition: mounted on 2.0mm Al-based PCB in size of 20x20mm

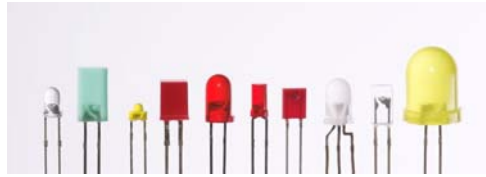
Typical Electrical & Optical Characteristics at Ta = 25°C (on metal core PCB)*

Items	Symbol	Condition	Min.	Typ.	Max.	Unit
Forward Voltage	V_f	$I_f = 450mA$	2.4	2.8	—	V
Reverse Current	I_R	$V_R = 5V$	—	—	10	μA
Luminous Flux	lumen	$I_f = 450mA$	21	32	—	lm
Dominant Wavelength	λ_D	$I_f = 450mA$	618	624	630	nm
50% Power Angle	$2\theta_{1/2}$	$I_f = 450mA$	—	105	—	deg

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Semiconductor Light Sources I

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Inorganic semiconductor materials



- ❑ [aluminum gallium arsenide](#) (AlGaAs) - red and [infrared](#)
- ❑ [aluminum gallium phosphide](#) (AlGaP) - green
- ❑ [aluminum gallium indium phosphide](#) (AlGaInP) - high-brightness orange-red, orange, yellow, and green
- ❑ [gallium arsenide phosphide](#) (GaAsP) - red, orange-red, [orange](#), and [yellow](#)
- ❑ [gallium phosphide](#) (GaP) - red, yellow and green
- ❑ [gallium nitride](#) (GaN) - green, pure green (or emerald green), and [blue](#)
- ❑ [indium gallium nitride](#) (InGaN) - near ultraviolet, bluish-green and blue
- ❑ [silicon carbide](#) (SiC) as substrate - blue
- ❑ [silicon](#) (Si) as substrate - blue (under development)
- ❑ [sapphire](#) (Al₂O₃) as substrate - blue
- ❑ [zinc selenide](#) (ZnSe) - blue
- ❑ [diamond](#) (C) - ultraviolet
- ❑ [aluminum nitride](#) (AlN), [aluminum gallium nitride](#) (AlGaN) - near to far [ultraviolet](#)

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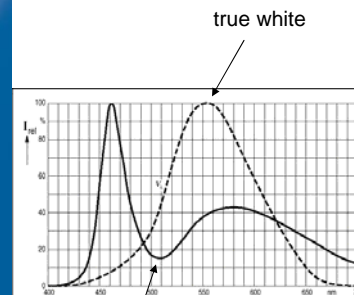
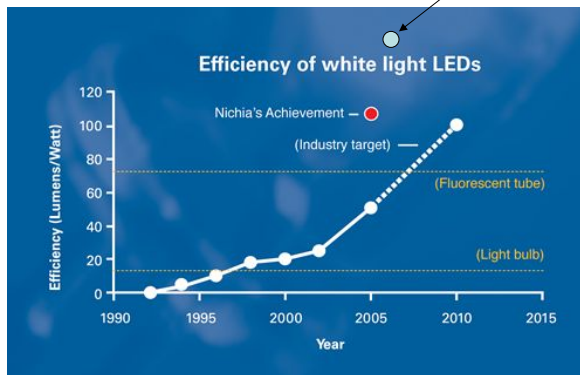
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White LED efficiency

❑ Goal is to replace everything with LEDs

Cree produced 131 lumen/W
06/20/2006



emitted wavelength (blue and converter material to yellow)

lumen = power weighted by luminosity function of human eye per unit of steradian

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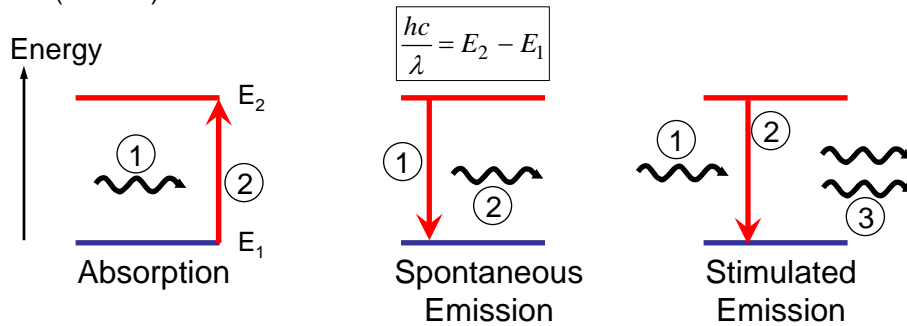
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Devices: Light-related

□ Three major methods for light to interact with a material:

- ❖ **Absorption**: incoming photon creates electron-hole pair (solar cell).
- ❖ **Spontaneous Emission**: electron-hole pair spontaneously decays to eject photon (LED).
- ❖ **Stimulated Emission**: incoming photon stimulates electron-hole pair to decay and eject another photon, i.e. one photon in → two photons out (LASER).



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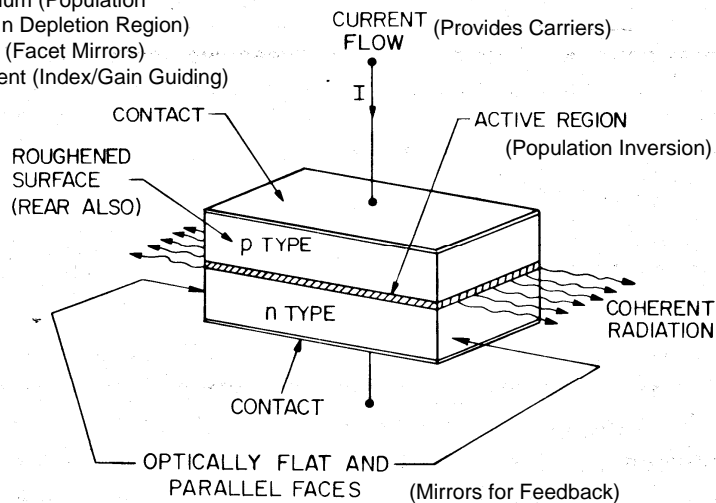
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Fabry-Perot Laser Geometry

A Laser Requires:

- 1.) Gain Medium (Population Inversion in Depletion Region)
- 2.) Feedback (Facet Mirrors)
- 3.) Confinement (Index/Gain Guiding)



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Semiconductor Lasers: Spectral Output

Lasing starts to occur when *gain* (due to population inversion) is greater than *losses* (due to absorption and mirror losses) of the cavity.

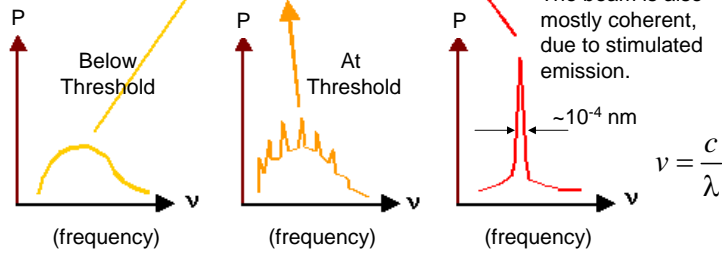
Light output

This is an *OPTICAL POWER VS CURRENT (PI) curve, not a current vs voltage (IV) curve.*

PI Curve
Threshold Current I_{th}
Linear Lasing Region (Above Threshold)

Linewidths of LDs ($\sim 10^{-4}$ nm) are much sharper than LEDs. The beam is also mostly coherent, due to stimulated emission.

Power Spectra at Different Output Powers



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Semiconductor Lasers: Multi-Mode Operation

Most commercial laser diodes have more than one dominant mode.

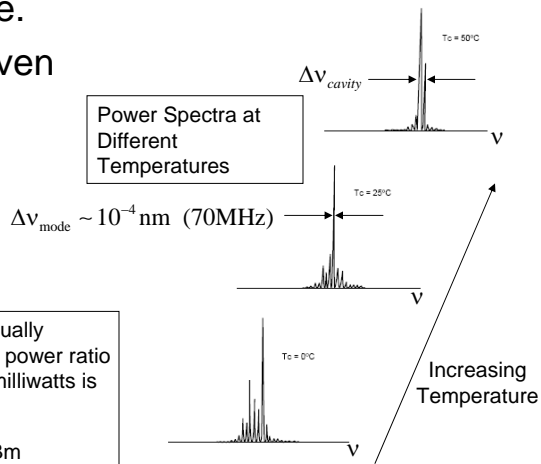
Mode spacing is given

by:
$$\Delta\nu_{cavity} = \frac{c}{2nL}$$

c = speed of light (3×10^8 m/sec)
 n = refractive index of cavity material (~ 3.5)
 L = cavity length

Optical Spectrum Analyzers (OSAs) usually specify power in terms of dBm (decibel power ratio referenced to one milliwatt). Power in milliwatts is given by

$$P = 10^{\frac{x}{10}} \text{ where } x \text{ is dBm}$$



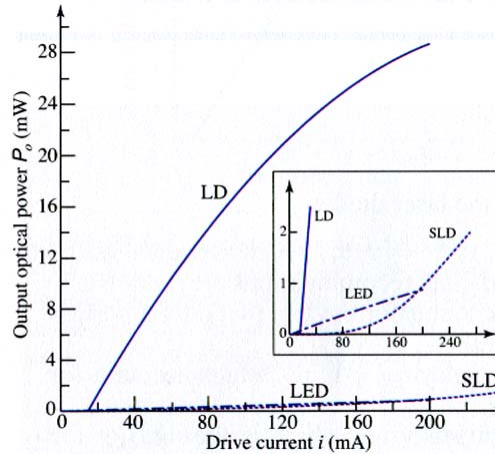
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PI Curves for Different Semiconductor Light Sources

- LED: Light Emitting Diode
(Lowest power output)
- LD: Laser Diode
(Highest power output)
- SLD: Super Luminescent Diode
(Higher power than LED)



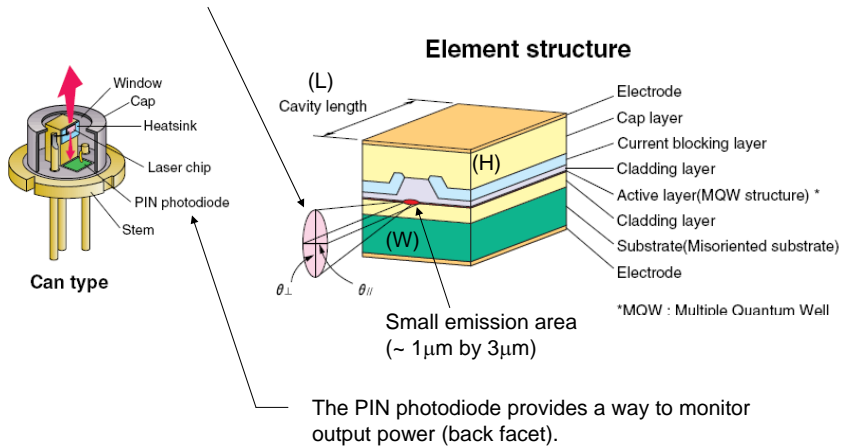
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LD Package and Structure

LD beams are elliptically shaped, due to diffraction from the small emission area at the front facet.

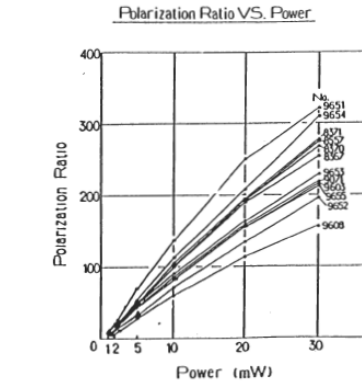


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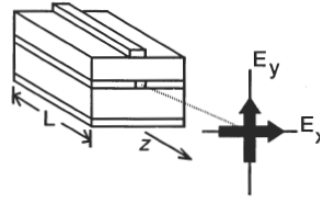
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LD Polarization Ratio



(Sharp LD)

$T_c = 25^\circ\text{C}$
 $NA = 0.40$



- polarization ratio = I_x / I_y
- mainly I_x due to waveguide
- ratio increases with power output

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Red LD Used in This Lab

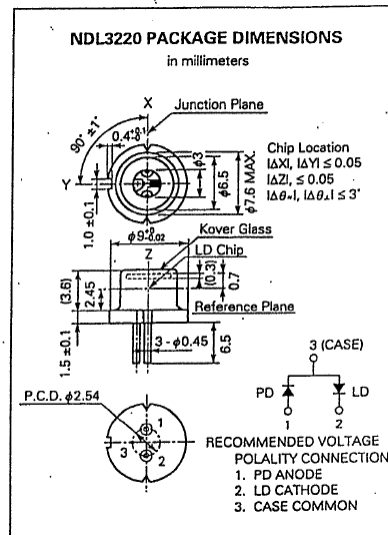
FEATURES

- Low Operating Current ($I_{op} = 30 \text{ mA TYP.}$)
- Low Operating Voltage ($V_{op} = 2.1 \text{ V TYP.}$)
- Wide Operating Case Temperature ($T_c = -10 \text{ to } +60^\circ\text{C}$)
- Peak Emission Wavelength ($\lambda = 670 \text{ nm TYP.}$)
- Fundamental Transverse Mode

ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$)

Optical Output Power	P_o	6.0	mW
Reverse Voltage	V_R	2.0	V
Operating Case Temperature	T_c	-10 to +60	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 to +85	$^\circ\text{C}$
Monitor PD			
Reverse Voltage	V_R	30	V
Forward Current	I_f	20	mA

(Full Spec Sheet on Website)



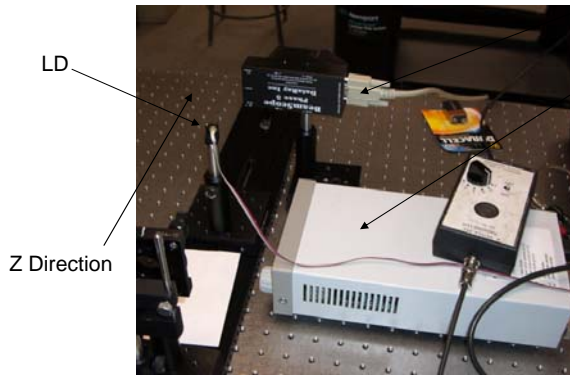
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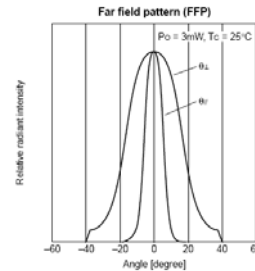
Measuring LD Beam Divergence

- ☐ Measure widths in x (\parallel) at two z distances, calculate angle. Use FWHM Irradiance.
- ☐ Repeat for y (\perp) profile.



Beam Scope Profile Measurement Device (Manual on Website)

LD Power Supply



Typical Catalog Graph

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The Concept of Radiance

(Mostly from Wikipedia)

- ☐ Radiance is useful because it indicates how much of the power emitted by an emitting surface will be received by an optical system looking at the surface from some angle of view. In this case, the solid angle of interest is the solid angle subtended by the optical system's entrance pupil. Since the eye is an optical system, radiance is a good indicator of how *bright* an object will appear.

Radiance is defined by

$$L = \frac{d^2\Phi}{dA d\Omega \cos \theta} \approx \frac{\Phi}{\Omega A \cos \theta}$$

where

L is the observed or measured radiance ($\text{W}\cdot\text{m}^{-2}\cdot\text{sr}^{-1}$), in the direction θ ,

Φ is the total radiant flux or power (W) emitted

θ is the angle between the surface normal and the specified direction,

A is the area of the source (m^2), and

Ω is the solid angle (sr) subtended by the observation or measurement.

The approximation only holds for small A and Ω where $\cos(\theta)$ is approximately constant.

The spectral radiance (radiance per unit wavelength) is written L_λ and the radiance per unit frequency is written L_ν .

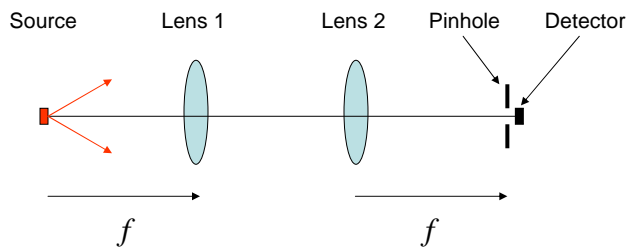
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Measuring Relative Radiance

- Place Source 1 at the front focus of lens 1.
- Measure the power through the pinhole.
- Repeat for Source 2.
- Relative radiance is the ratio of the power measurements.



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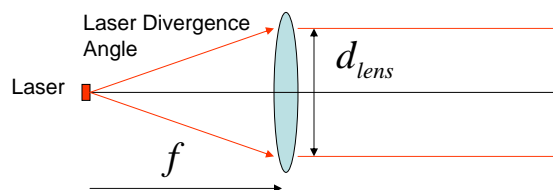
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LD Collimation

- Numerical Aperture (NA) of the lens:

$$NA = \sin \theta_{\text{marginal}} \sim \frac{d_{\text{lens}}}{2f}$$

- NA of the laser is approximately the sine of the divergence angle (can be different in x and y)
- Match NA of laser beam to NA of lens



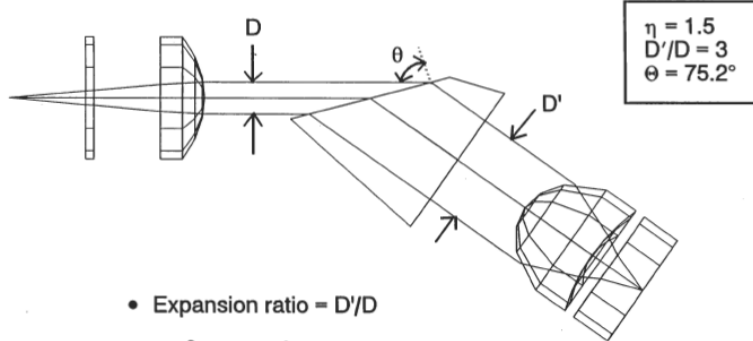
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LD Circularization

Single Prism



- Expansion ratio = D'/D
- $\cos^2 \theta = \frac{n^2 - 1}{(nD'/D)^2 - 1}$